Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination TAKESHITA, NOBUO	
10/021,000		
Examiner	Art Unit	
Kim-Kwok CHU	2627	

SEARCHED				
Class	Subclass	Date	Examiner	
369	44.14	10/17/2006	кс	
369	44.15	10/17/2006	кс	
369	44.16	10/17/2006	кс	
369	44.22	10/17/2006	кс	
369	44.18	10/17/2006	кс	
369	53.19	10/17/2006	кс	
369	369	10/17/2006	кс	
310	90	10/17/2006	кс	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
East Search Updated	10/17/2006	kc